UNISONIC TECHNOLOGIES CO., LTD

4NM80Z-U2 Power MOSFET

4.0A, 800V N-CHANNEL POWER MOSFET

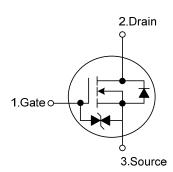
DESCRIPTION

The UTC **4NM80Z-U2** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient AC to DC converters and bridge circuits.

■ FEATURES

- * $R_{DS(ON)} \le 2.0 \Omega @ V_{GS} = 10V, I_D = 2.0A$
- * High Switching Speed

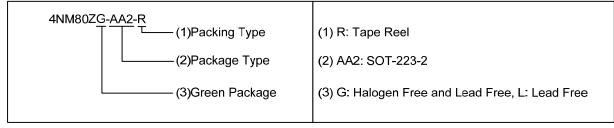
■ SYMBOL



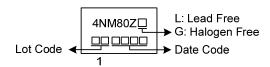
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
4NM80ZL-AA2-R	4NM80ZG-AA2-R	SOT-223-2	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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4NM80Z-U2 Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	800	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Drain Current	Continuous	I_D	4	Α	
	Pulsed (Note 2)	I_{DM}	8	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	115	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.6	V/ns	
Power Dissipation		P_D	4	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 159mH, I_{AS} = 1.2A, V_{DD} = 50V, R_G = 25 Ω Starting T_J = 25°C
- 4. $I_{SD} \le 4.0A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	150	°C/W	
Junction to Case	θ_{JC}	31.25	°C/W	

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

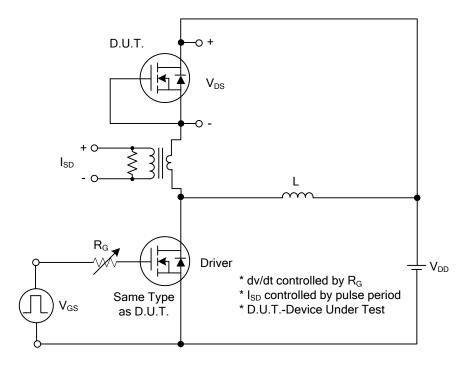
■ **ELECTRICAL CHARACTERISTICS** (T_J = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	V_{GS} =0V, I_D = 250 μ A	800			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =800V, V _{GS} =0V			10	μΑ
Gate-Source Leakage Current	Forward	I _{GSS}	V_{GS} =20V, V_{DS} =0V			10	μΑ
	Reverse		V _{GS} =-20V, V _{DS} =0V			-10	μΑ
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5		4.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =2.0A			2.0	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	-\/ -0\/ \/ -25\/		288		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V f=1.0 MHz		216		pF
Reverse Transfer Capacitance		C _{RSS}	1-1.0 1011 12		19		pF
SWITCHING CHARACTERISTICS	3						
Total Gate Charge (Note 1)		Q_{G}	V _{DS} =640V, V _{GS} =10V,		15		nC
Gateource Charge		Q_GS	I _D =4.0A, I _G =1mA		6		nC
Gate-Drain Charge		Q_GD	(Note 1, 2)		4		nC
Turn-on Delay Time (Note 1)		t _{D(ON)}	./ _400)/		11		ns
Rise Time		t_R	V_{DS} =100V, V_{GS} =10V, I_{D} =4.0A, R_{G} =25 Ω		20		ns
Turn-off Delay Time		$t_{D(OFF)}$	(Note 1, 2)		85		ns
Fall-Time		t⊧	(14010-1, 2)		40		ns
SOURCE- DRAIN DIODE RATING	S AND CH	ARACTERIS	TICS				
Maximum Body-Diode Continuous Current		Is				4	Α
Maximum Body-Diode Pulsed Current		I _{SM}				8	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =4.0A, V _{GS} =0V			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	I _S =4.0A, V _{GS} =0V		310		ns
Reverse Recovery Charge		Qrr	dI _F /dt=100A/μs (Note1)		2.1		μC

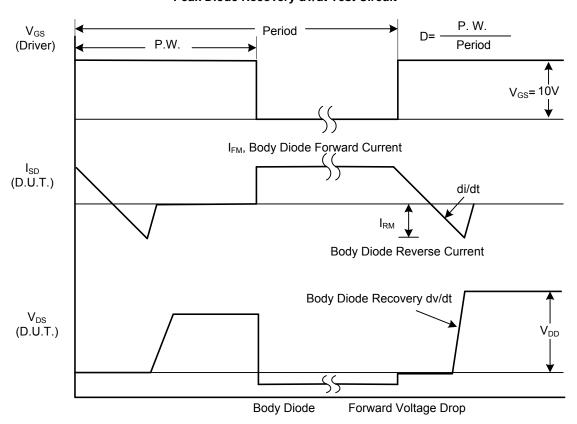
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



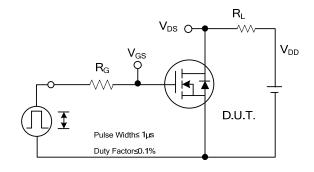
Peak Diode Recovery dv/dt Test Circuit

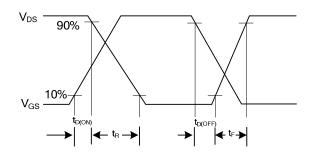


Peak Diode Recovery dv/dt Waveforms

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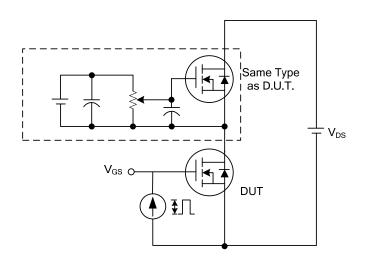
■ TEST CIRCUITS AND WAVEFORMS

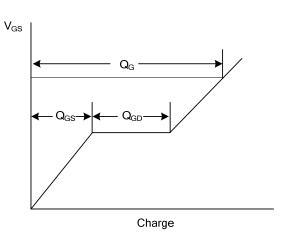




Switching Test Circuit

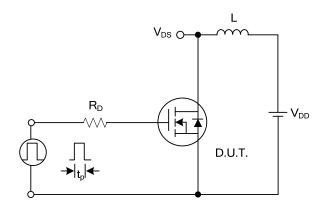
Switching Waveforms

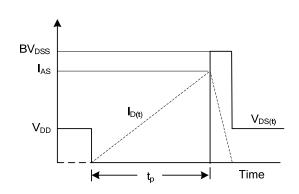




Gate Charge Test Circuit

Gate Charge Waveform

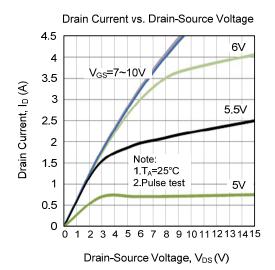


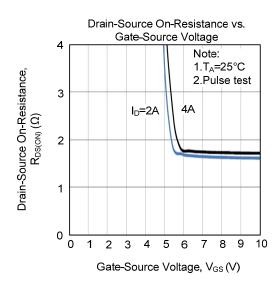


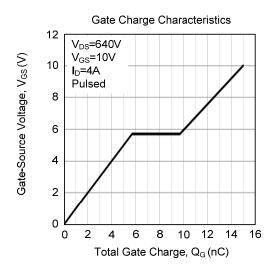
Unclamped Inductive Switching Test Circuit

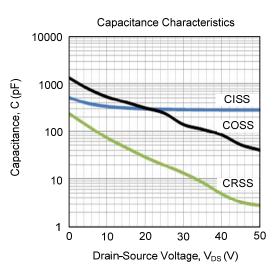
Unclamped Inductive Switching Waveforms

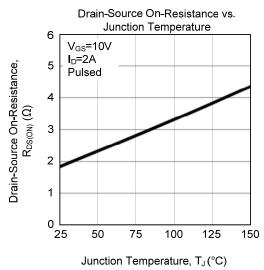
■ TYPICAL CHARACTERISTICS

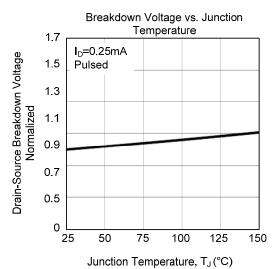




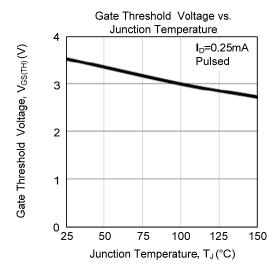


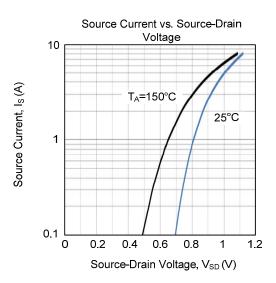


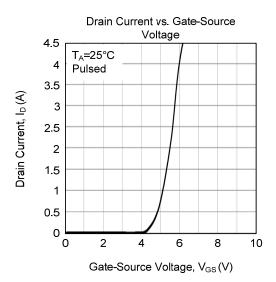


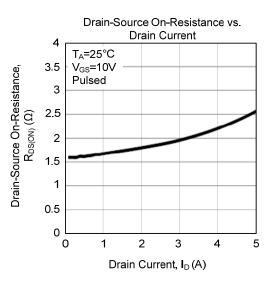


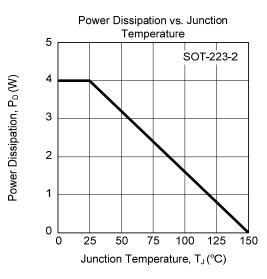
■ TYPICAL CHARACTERISTICS (Cont.)

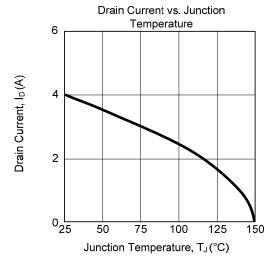




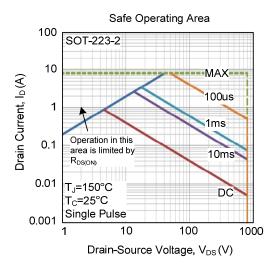








■ TYPICAL CHARACTERISTICS (Cont.)



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